



PJ2301

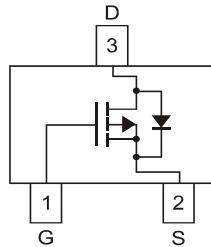
20V P-Channel Enhancement Mode MOSFET

FEATURES

- $R_{DS(ON)}$, V_{GS} @ -1.8V, I_D @ -1.5A=200m Ω
- $R_{DS(ON)}$, V_{GS} @ -4.5V, I_D @ -2.2A=105m Ω
- Advanced Trench Process Technology
- High Density Cell Design For Ultra Low On-Resistance
- Specially Designed for DC/DC converters
- Low gate charge
- In compliance with EU RoHS 2002/95/EC directives

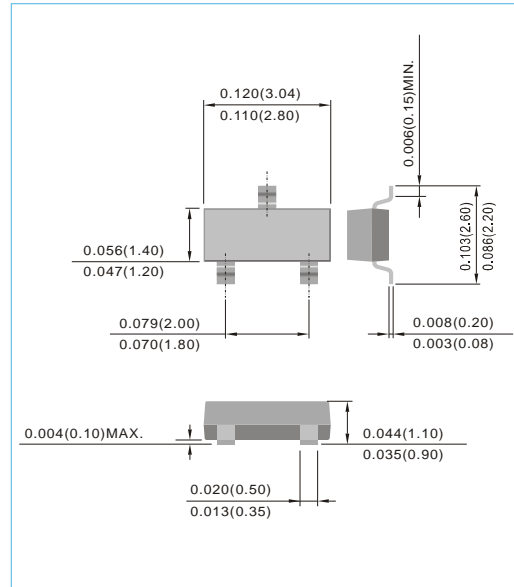
MECHANICAL DATA

- Case: SOT-23 Package
- Terminals : Solderable per MIL-STD-750, Method 2026
- Marking : 01



SOT-23

Unit : inch(mm)



Maximum Ratings and Thermal Characteristics ($T_A=25^\circ\text{C}$ unless otherwise noted)

| PARAMETER | | Symbol | Limit | Units |
|--|--------------------|-----------------|------------------------|---------------------------|
| Drain-Source Voltage | | V_{DS} | -20 | V |
| Gate-Source Voltage | | V_{GS} | ± 8 | V |
| Continuous Drain Current (Notes 1) | Steady-State | I_D | $T_A=25^\circ\text{C}$ | -1.75 |
| | Steady-State | | $T_A=70^\circ\text{C}$ | -1.4 |
| | $t \leq 5\text{s}$ | | $T_A=25^\circ\text{C}$ | -2 |
| Pulsed Drain Current (Notes 1) | | I_{DM} | 10 | A |
| Power Dissipation (Notes 2) | | P_D | $T_A=25^\circ\text{C}$ | 700 |
| | | | $T_A=70^\circ\text{C}$ | 450 |
| Typical Thermal Resistance (Notes 1) | | $R_{\theta JA}$ | 175 | $^\circ\text{C}/\text{W}$ |
| Typical Thermal Resistance (Notes 1) | | $R_{\theta JL}$ | 65 | $^\circ\text{C}/\text{W}$ |
| Operating Junction and Storage Temperature Range | | T_J, T_{STG} | -55 to + 150 | $^\circ\text{C}$ |

NOTES:

1. Mounted on minimum pad layout.
2. Mounted on 50cm² copper pad area.



PJ2301

ELECTRICAL CHARACTERISTICS

| Parameter | Symbol | Test Condition | Min. | Typ. | Max. | Units |
|------------------------------------|--------------|--|------|-------|------|-------|
| Static | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0V, I_D = -250\mu A$ | -20 | - | - | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D = -250\mu A$ | -0.5 | -0.7 | -0.9 | V |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = -4.5V, I_D = -2.2A$ | - | 90 | 105 | mΩ |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = -2.5V, I_D = -1.7A$ | - | 120 | 140 | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = -1.8V, I_D = -1.5A$ | - | 170 | 200 | |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = -16V, V_{GS}=0V$ | - | - | -1 | μA |
| Gate Body Leakage | I_{GSS} | $V_{GS} = \pm 8V, V_{DS}=0V$ | - | - | ±100 | nA |
| Dynamic | | | | | | |
| Forward Transconductance | g_{FS} | $V_{DS} = -10V, I_D = -1.7A$ | 4 | 6 | - | S |
| Total Gate Charge | Q_g | $V_{DS} = -10V, I_D = -2.2A$ $V_{GS} = -4.5V$ | - | 4 | - | nC |
| Gate-Source Charge | Q_{gs} | | - | 0.5 | - | |
| Gate-Drain Charge | Q_{gd} | | - | 1 | - | |
| Turn-On Time | t_{on} | $V_{DD} = -16V,$ $I_D = -2.2A, V_{GS} = -4.5V$ $R_{GEN} = 2.5\Omega$ | - | 8 | - | ns |
| Turn-Off Time | t_{off} | | - | 35 | - | |
| Turn-On Rise Time | t_r | | - | 15 | - | |
| Turn-Off Fall Time | t_f | | - | 25 | - | |
| Input Capacitance | C_{iss} | $V_{DS} = -10V, V_{GS}=0V$ $f=1.0MHz$ | - | 200 | 300 | pF |
| Output Capacitance | C_{oss} | | - | 90 | 140 | |
| Reverse Transfer Capacitance | C_{rss} | | - | 40 | 60 | |
| Gate Resistance | R_g | $V_{DS}=0V, V_{GS}=0V$ $f=1.0MHz$ | - | 12 | - | Ω |
| Source-Drain Diode | | | | | | |
| Max. Diode Forward Current | I_s | - | - | - | -2 | A |
| Diode Forward Voltage | V_{SD} | $I_s = -1A, V_{GS}=0V$ | - | -0.79 | -1 | V |
| Body-Diode Reverse Recovery Time | t_{rr} | $I_s = -2.1A, di/dt=100A/\mu s$ | - | 30 | - | ns |
| Body-Diode Reverse Recovery Charge | Q_{rr} | | - | 12 | - | nC |



PJ2301

CHARACTERISTIC CURVES

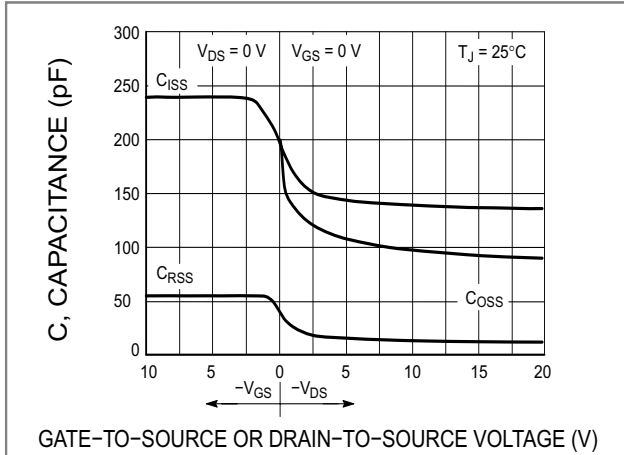


Fig.1 Capacitance Variation

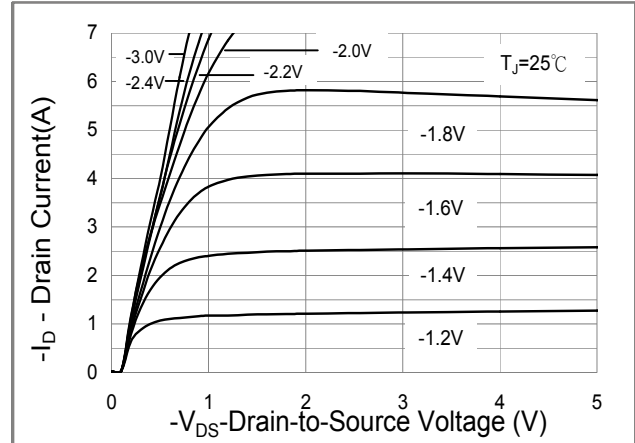


Fig.2 On-Region Characteristics

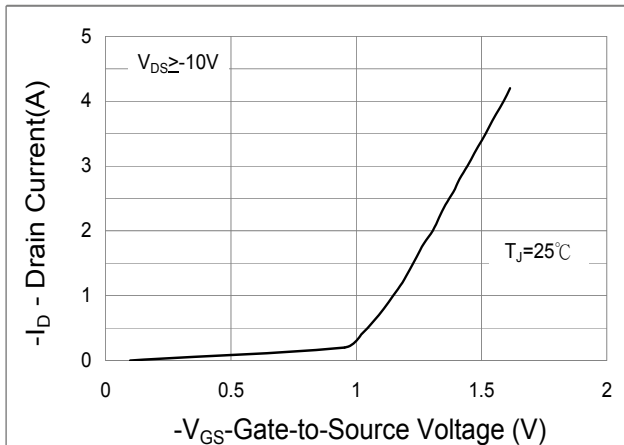


Fig.3 Transfer Characteristics

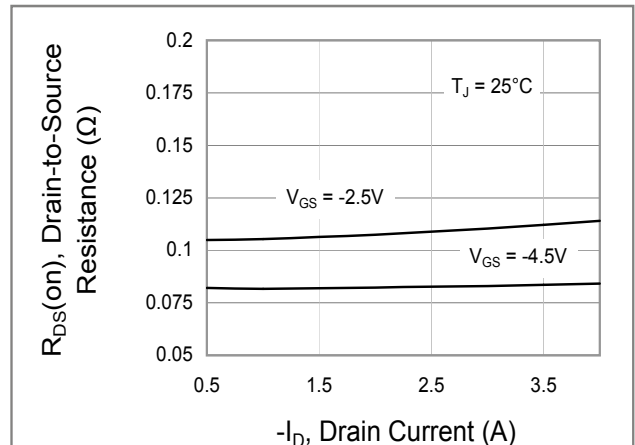


Fig.4 On-Resistance vs. Drain Current and Gate Voltage

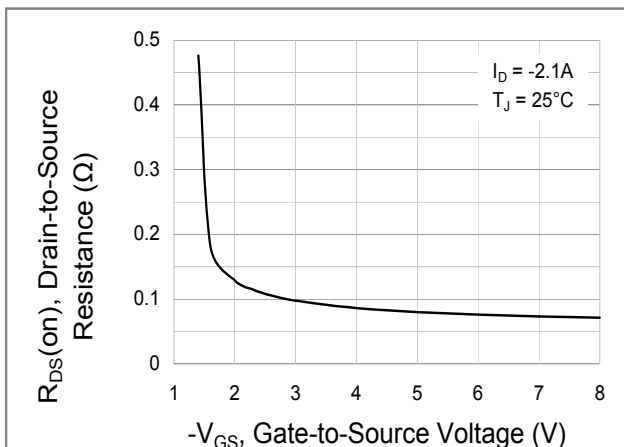


Fig.5 On-Resistance vs. Gate-Source Voltage

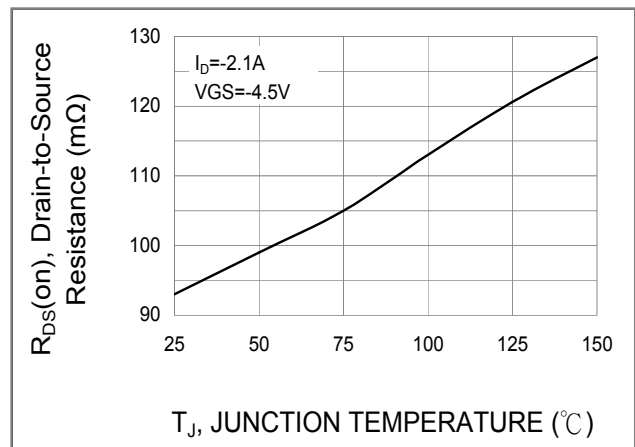


Fig.6 On-Resistance Variation with Temperature



PJ2301

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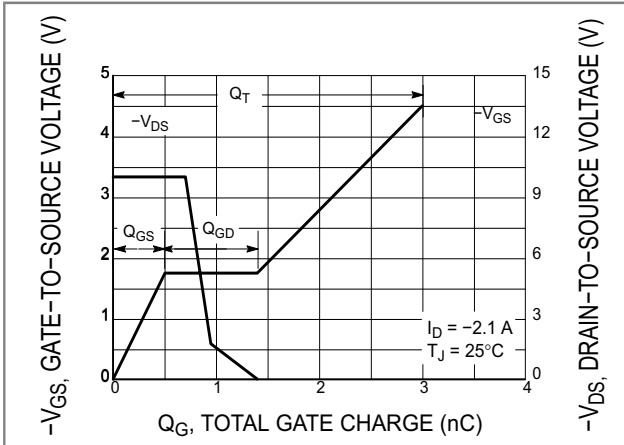


Fig.7 Gate-to-Source and Drain-to-Source vs. Total Charge

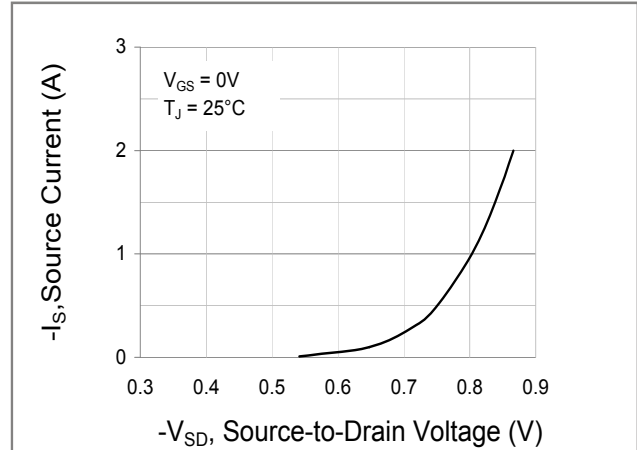


Fig.8 Diode Forward Voltage vs. Current

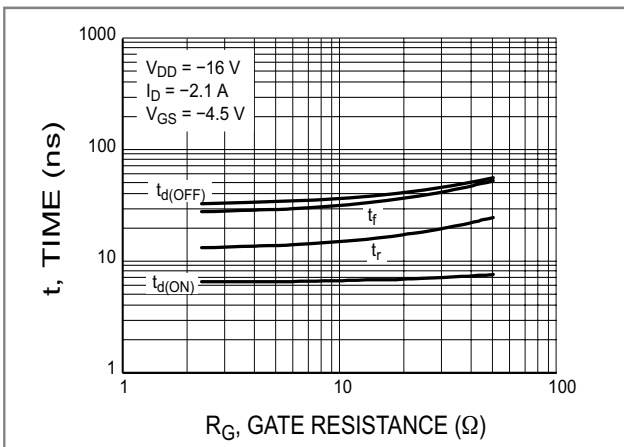


Fig.9 Resistive Switching Time Variation vs. Gate Resistance

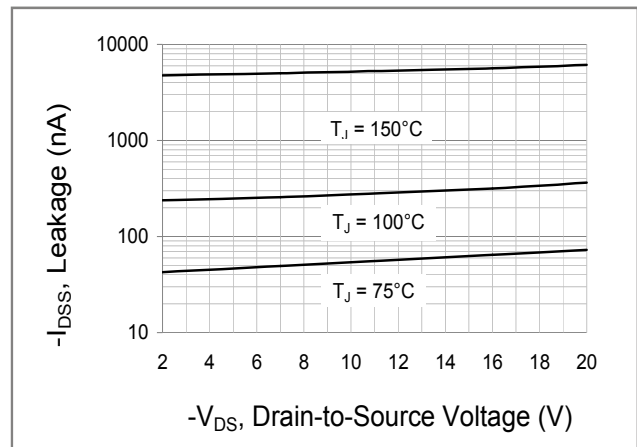


Fig.10 Drain-to-Source Leakage Current vs. Voltage

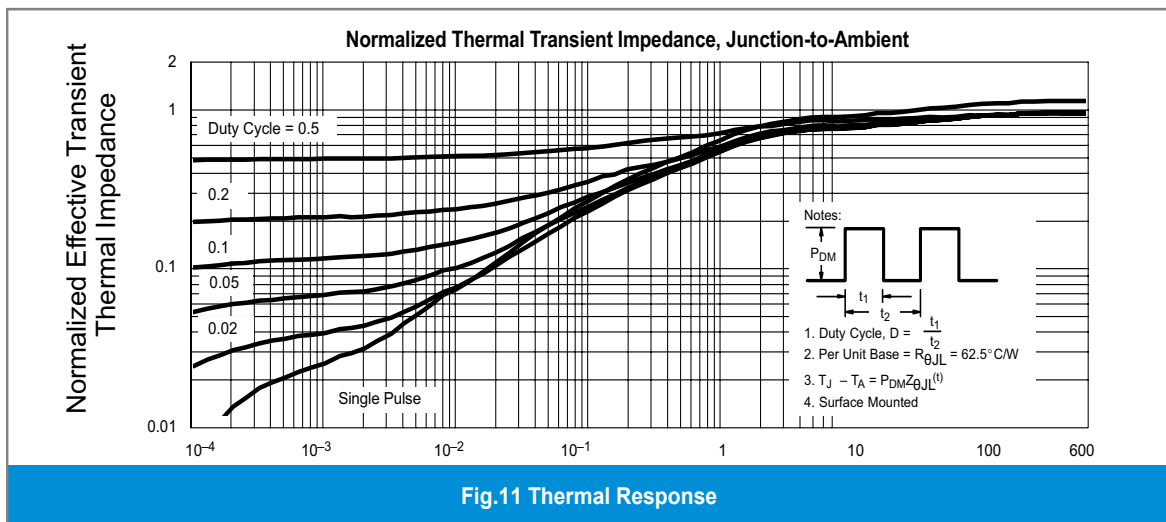


Fig.11 Thermal Response